

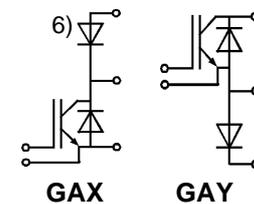
Absolute Maximum Ratings		Values		Units
Symbol	Conditions <sup>1)</sup>			
V <sub>CES</sub>		1200		V
V <sub>CGR</sub>	R <sub>GE</sub> = 20 kΩ	1200		V
I <sub>C</sub>	T <sub>case</sub> = 25/80 °C	300 / 220		A
I <sub>CM</sub>	T <sub>case</sub> = 25/80 °C; t <sub>p</sub> = 1 ms	600 / 440		A
V <sub>GES</sub>		± 20		V
P <sub>tot</sub>	per IGBT, T <sub>case</sub> = 25 °C	1660		W
T <sub>j</sub> , (T <sub>stg</sub> )		-40 ... +150 (125)		°C
V <sub>isol</sub>	AC, 1 min.	2500		V
humidity	DIN 40 040	Class F		
climate	DIN IEC 68 T.1	40/125/56		
Diodes		Inverse	Series <sup>6)</sup>	
I <sub>F</sub> = -I <sub>C</sub>	T <sub>case</sub> = 25/80 °C	260 / 180	350 / 230	A
I <sub>FM</sub> = -I <sub>CM</sub>	T <sub>case</sub> = 25/80 °C; t <sub>p</sub> = 1 ms	600 / 440	580 / 440	A
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; sin.; T <sub>j</sub> = 150 °C	2200	2900	A
I <sup>2</sup> t	t <sub>p</sub> = 10 ms; T <sub>j</sub> = 150 °C	24200	42000	A <sup>2</sup> s

## SEMITRANS® M IGBT Modules

**SKM 300 GAX 123 D <sup>6)</sup>**  
**SKM 300 GAY 123 D <sup>6)</sup>**



## SEMITRANS 3



### Features

- N channel, Homogeneous Silicon structure (NPT-IGBT)
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to 6 \* I<sub>Cnom</sub>
- Latch-up free
- Fast & soft inverse CAL diodes <sup>8)</sup>
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (12 mm) and creepage distances (20 mm).

### Typical Applications

- Switching, not for linear use
- AC-inverter drives
- Regen. Drives

<sup>1)</sup> T<sub>case</sub> = 25 °C, unless otherwise specified

<sup>2)</sup> I<sub>F</sub> = - I<sub>C</sub>, V<sub>R</sub> = 600 V, - di<sub>F</sub>/dt = 2000 A/μs, V<sub>GE</sub> = 0 V

<sup>3)</sup> Use V<sub>GEoff</sub> = -5 ... -15 V

<sup>5)</sup> see fig. 2 + 3; R<sub>Goff</sub> = 4,7 Ω

<sup>6)</sup> The series diodes have the data of the inverse diodes of SKM 400 GA 123 D

<sup>8)</sup> CAL = Controlled Axial Lifetime Technology.

### Cases and mech. data

→ B 6 - 176

Diagrams of IGBT and inverse Diode → B 6 - 170 ...

of series diodes → B 6 - 186

Characteristics		min.	typ.	max.	Units
Symbol	Conditions <sup>1)</sup>				
V <sub>(BR)CES</sub>	V <sub>GE</sub> = 0, I <sub>C</sub> = 4 mA	≥ V <sub>CES</sub>	-	-	V
V <sub>GE(th)</sub>	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 8 mA	4,5	5,5	6,5	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 } T <sub>j</sub> = 25 °C V <sub>CE</sub> = V <sub>CES</sub> } T <sub>j</sub> = 125 °C	-	3	4,5	mA
I <sub>GES</sub>	V <sub>GE</sub> = 20 V, V <sub>CE</sub> = 0 V	-	-	0,4	μA
V <sub>CESat</sub>	I <sub>C</sub> = 200 A } V <sub>GE</sub> = 15 V; I <sub>C</sub> = 300 A } T <sub>j</sub> = 25 (125) °C	-	2,5(3,1)	3(3,7)	V
V <sub>CESat</sub>		-	3(3,8)	-	V
g <sub>fs</sub>	V <sub>CE</sub> = 20 V, I <sub>C</sub> = 200 A	108	150	-	S
C <sub>CHC</sub>	per IGBT	-	-	700	pF
C <sub>ies</sub>	V <sub>GE</sub> = 0	-	18	24	nF
C <sub>oes</sub>	V <sub>CE</sub> = 25 V	-	2,5	3,2	nF
C <sub>res</sub>	f = 1 MHz	-	1,0	1,3	nF
L <sub>CE</sub>		-	-	20	nH
t <sub>d(on)</sub>	V <sub>CC</sub> = 600 V	-	250	400	ns
t <sub>r</sub>	V <sub>GE</sub> = + 15 V / - 15 V <sup>3)</sup>	-	90	160	ns
t <sub>d(off)</sub>	I <sub>C</sub> = 200 A, ind. load	-	550	700	ns
t <sub>f</sub>	R <sub>Gon</sub> = R <sub>Goff</sub> = 4,7 Ω	-	70	100	ns
E <sub>on</sub> <sup>5)</sup>	T <sub>j</sub> = 125 °C	-	28	-	mWs
E <sub>off</sub> <sup>5)</sup>		-	26	-	mWs
Inverse Diode <sup>8)</sup>					
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 200 A } V <sub>GE</sub> = 0 V; I <sub>F</sub> = 300 A } T <sub>j</sub> = 25 (125) °C	-	2,0(1,8)	2,5	V
V <sub>F</sub> = V <sub>EC</sub>		-	2,25(2,1)	-	V
V <sub>TO</sub>	T <sub>j</sub> = 125 °C	-	1,1	1,2	V
r <sub>T</sub>	T <sub>j</sub> = 125 °C	-	3	5,5	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 200 A; T <sub>j</sub> = 25 (125) °C <sup>2)</sup>	-	70(105)	-	A
Q <sub>rr</sub>	I <sub>F</sub> = 200 A; T <sub>j</sub> = 25 (125) °C <sup>2)</sup>	-	10(26)	-	μC
Series Diode <sup>8) 6)</sup>					
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 200 A } V <sub>GE</sub> = 0 V; I <sub>F</sub> = 300 A } T <sub>j</sub> = 25 (125) °C	-	1,9(1,7)	2,4	V
V <sub>F</sub> = V <sub>EC</sub>		-	2,1(1,8)	-	V
V <sub>TO</sub>	T <sub>j</sub> = 125 °C	-	-	1,2	V
r <sub>T</sub>	T <sub>j</sub> = 125 °C	-	3	3,5	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 200 A; T <sub>j</sub> = 25 (125) °C <sup>2)</sup>	-	80(140)	-	ns
Q <sub>rr</sub>	I <sub>F</sub> = 200 A; T <sub>j</sub> = 25 (125) °C <sup>2)</sup>	-	10(34)	-	μC
Thermal Characteristics					
R <sub>thjc</sub>	per IGBT	-	-	0,075	°C/W
R <sub>thjc</sub>	per inverse/series diode	-	-	0,18/0,15	°C/W
R <sub>thch</sub>	per module	-	-	0,038	°C/W

# SKM 300 GAX(Y) 123 D

## SEMITRANS 3

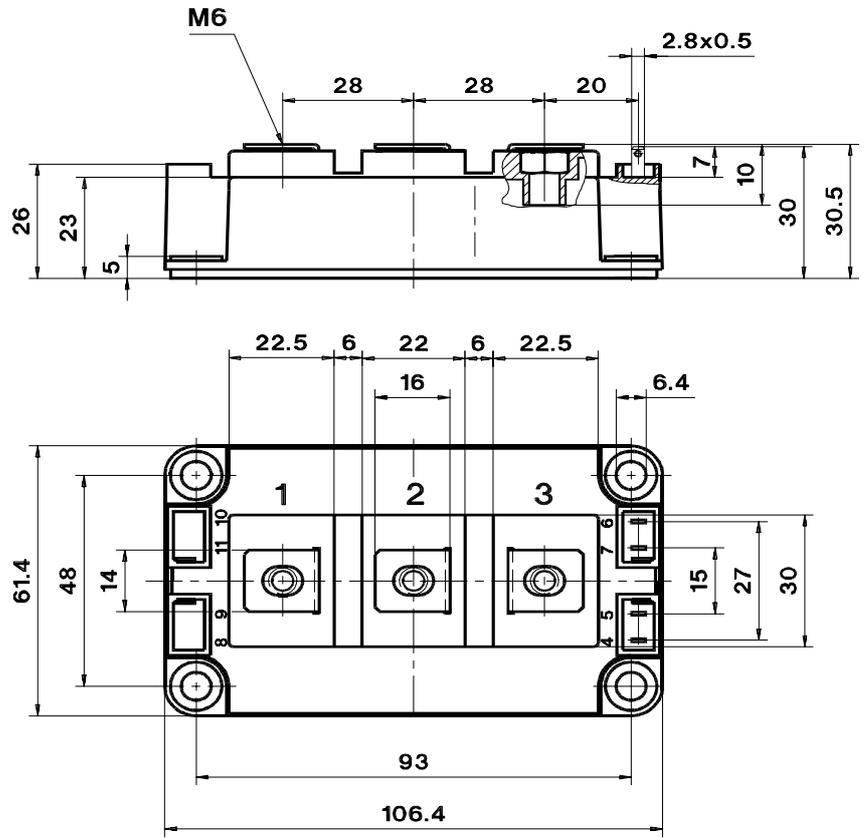
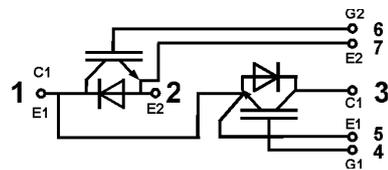
Case D 56

UL Recognized

File no. E 63 532

CASE056

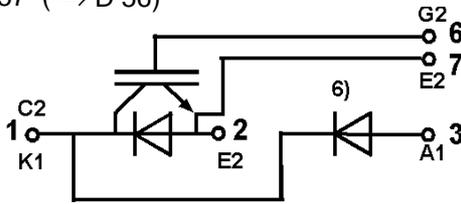
## SKM 300 GB 123 D



Dimensions in mm

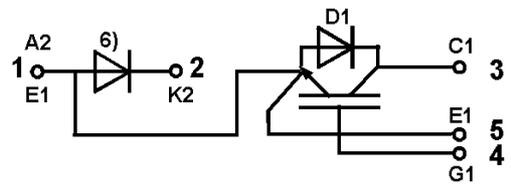
## SKM 300 GAX 123 D

Case D 57 (→ D 56)



## SKM 300 GAY 123 D

Case D 58 (→ D 56)



Case outline and circuit diagrams

Mechanical Data			Values			Units
Symbol	Conditions		min.	typ.	max.	
M <sub>1</sub>	to heatsink, SI Units to heatsink, US Units	(M6)	3 27	—	5 44	Nm lb.in.
M <sub>2</sub>	for terminals, SI Units for terminals, US Units	(M5)	2,5 22	—	5 44	Nm lb.in.
a			—	—	5x9,81	m/s <sup>2</sup>
w			—	—	325	g

<sup>6)</sup> Series diode → B 6 – 175, remark 6.

**This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.**

Three devices are supplied in one SEMIBOX A without mounting hardware, which can be ordered separately under Ident No. 33321100 (for 10 SEMITRANS 3). Larger packing units of 12 and 20 pieces are used if suitable  
Accessories → B 6 – 4.  
SEMIBOX → C – 1.

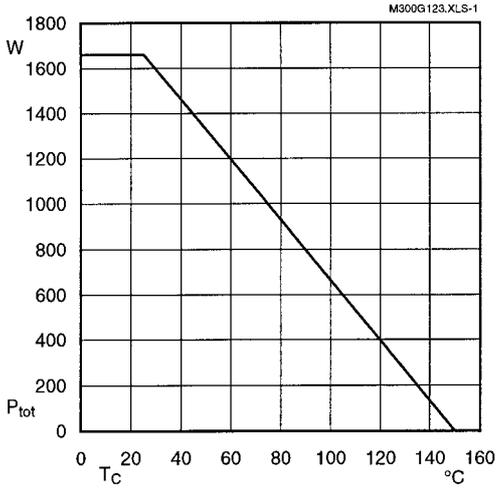


Fig. 1 Rated power dissipation  $P_{tot} = f(T_C)$

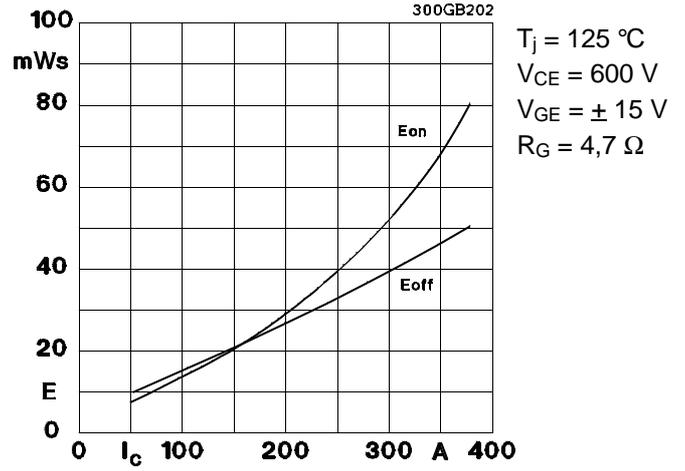


Fig. 2 Turn-on /-off energy =  $f(I_C)$

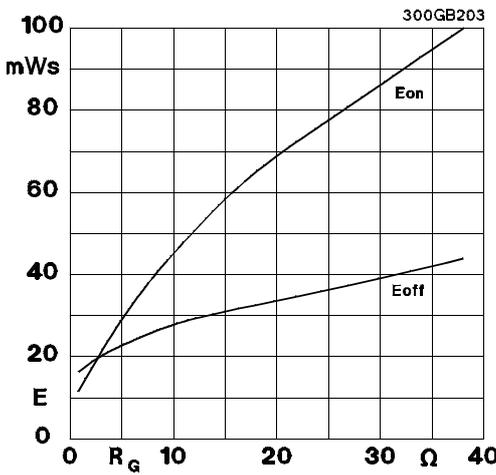


Fig. 3 Turn-on /-off energy =  $f(R_G)$

$T_j = 125\text{ °C}$   
 $V_{CE} = 600\text{ V}$   
 $V_{GE} = \pm 15\text{ V}$   
 $I_C = 200\text{ A}$

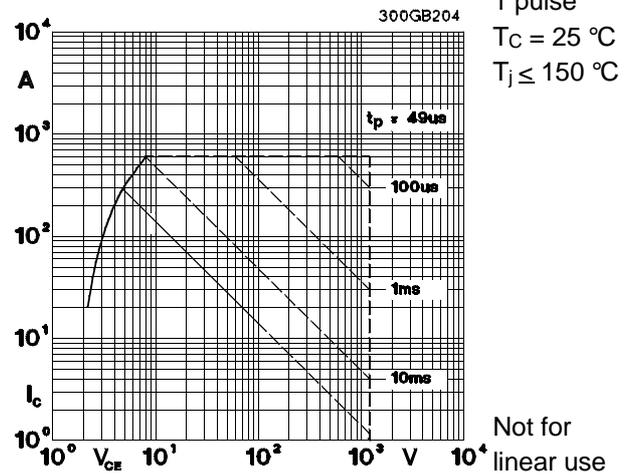


Fig. 4 Maximum safe operating area (SOA)  $I_C = f(V_{CE})$

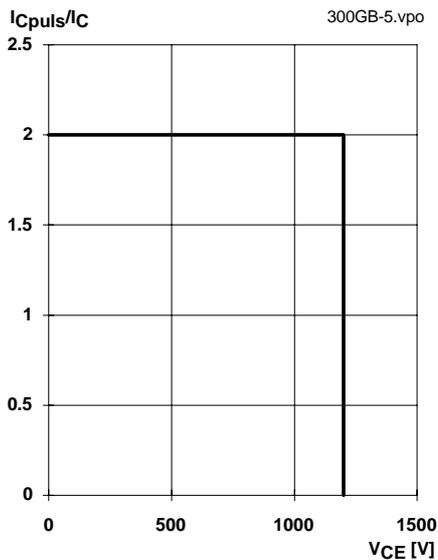


Fig. 5 Turn-off safe operating area (RBSOA)

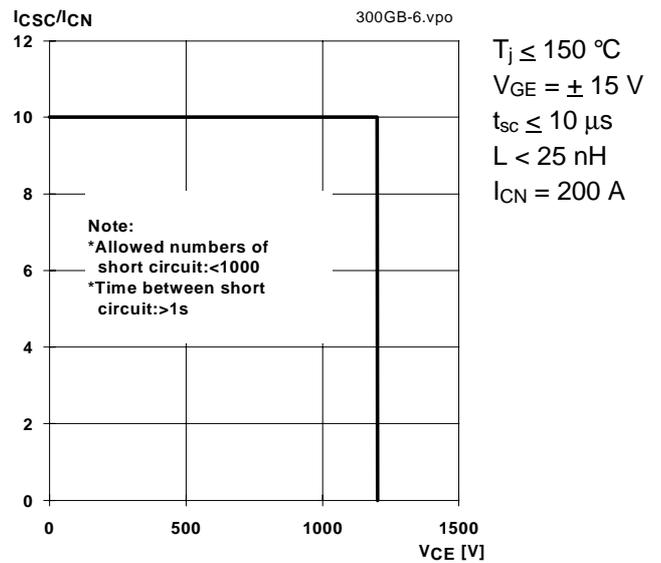


Fig. 6 Safe operating area at short circuit  $I_C = f(V_{CE})$

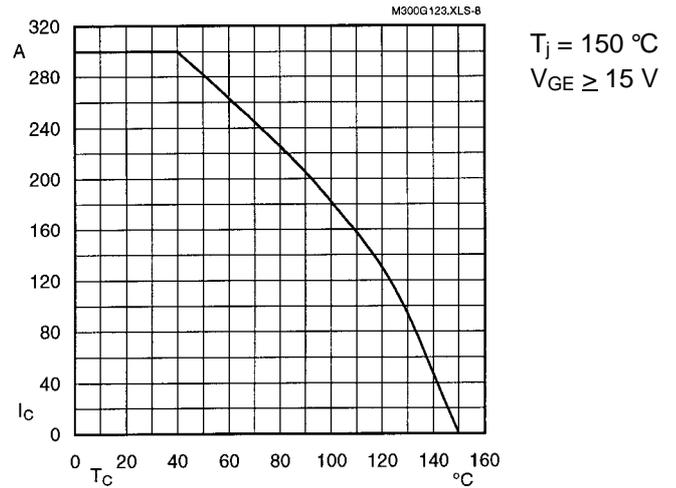


Fig. 8 Rated current vs. temperature  $I_C = f(T_C)$

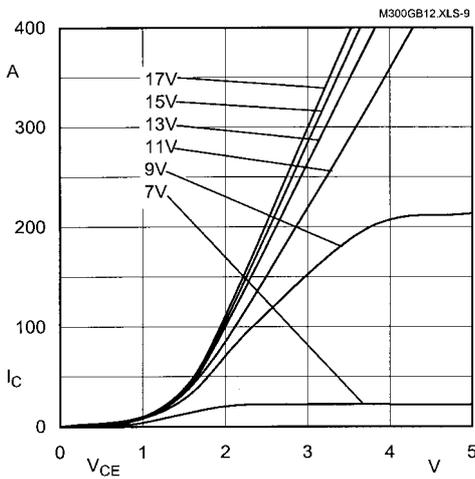


Fig. 9 Typ. output characteristic,  $t_p = 80\text{ }\mu\text{s}$ ;  $25\text{ }^\circ\text{C}$

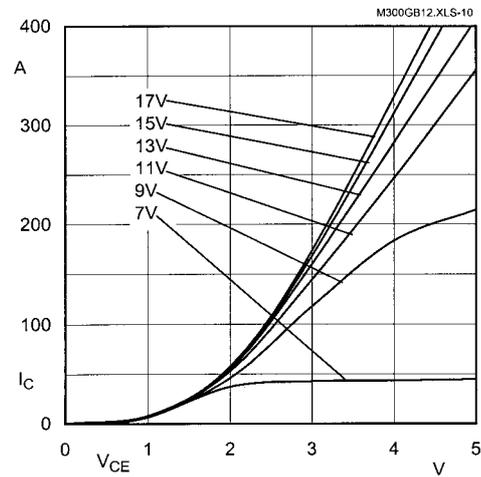


Fig. 10 Typ. output characteristic,  $t_p = 80\text{ }\mu\text{s}$ ;  $125\text{ }^\circ\text{C}$

$$P_{\text{cond}(t)} = V_{CE\text{sat}(t)} \cdot I_{C(t)}$$

$$V_{CE\text{sat}(t)} = V_{CE(TO)(T_j)} + r_{CE(T_j)} \cdot I_{C(t)}$$

$$V_{CE(TO)(T_j)} \leq 1,5 + 0,002 (T_j - 25) \text{ [V]}$$

$$\text{typ.: } r_{CE(T_j)} = 0,005 + 0,00002 (T_j - 25) \text{ } [\Omega]$$

$$\text{max.: } r_{CE(T_j)} = 0,0075 + 0,000025 (T_j - 25) \text{ } [\Omega]$$

$$\text{valid for } V_{GE} = +15 \begin{matrix} +2 \\ -1 \end{matrix} \text{ [V]; } I_C > 0,3 I_{C\text{nom}}$$

Fig. 11 Saturation characteristic (IGBT)  
Calculation elements and equations

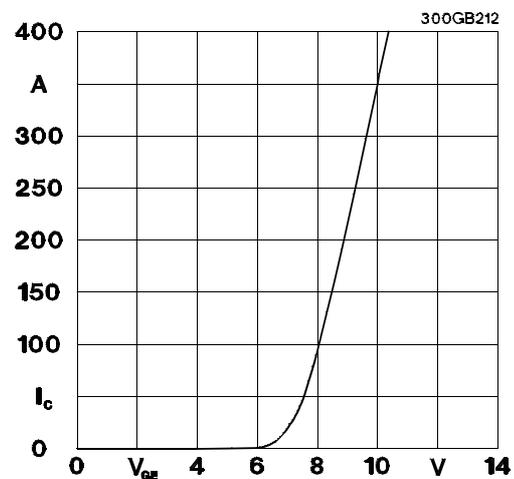


Fig. 12 Typ. transfer characteristic,  $t_p = 80\text{ }\mu\text{s}$ ;  $V_{CE} = 20\text{ V}$

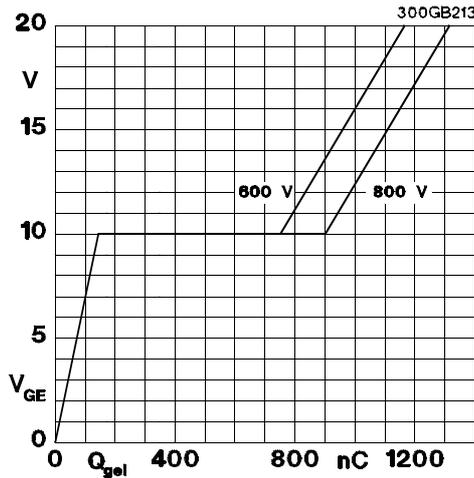
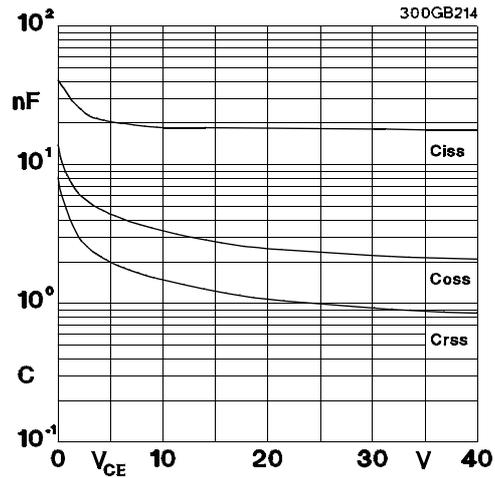


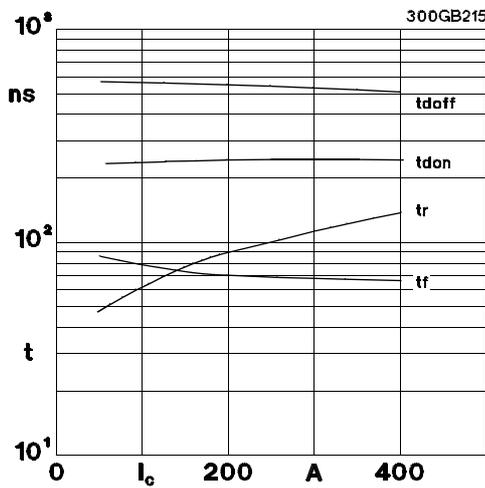
Fig. 13 Typ. gate charge characteristic

$I_{Cpuls} = 300 \text{ A}$



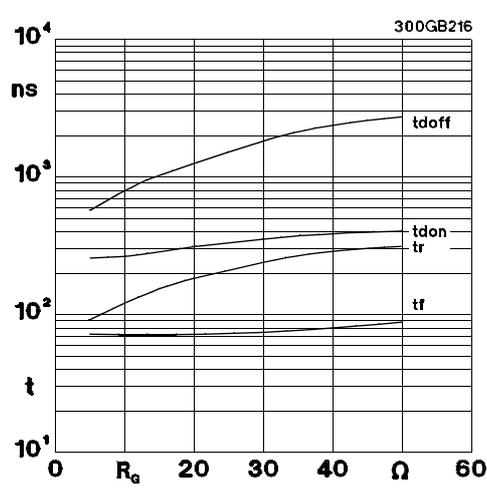
$V_{GE} = 0 \text{ V}$   
 $f = 1 \text{ MHz}$

Fig. 14 Typ. capacitances vs.  $V_{CE}$



$T_j = 125 \text{ }^\circ\text{C}$   
 $V_{CE} = 600 \text{ V}$   
 $V_{GE} = \pm 15 \text{ V}$   
 $R_{Gon} = 4,7 \text{ } \Omega$   
 $R_{Goff} = 4,7 \text{ } \Omega$   
induct. load

Fig. 15 Typ. switching times vs.  $I_c$



$T_j = 125 \text{ }^\circ\text{C}$   
 $V_{CE} = 600 \text{ V}$   
 $V_{GE} = \pm 15 \text{ V}$   
 $I_c = 200 \text{ A}$   
induct. load

Fig. 16 Typ. switching times vs. gate resistor  $R_G$

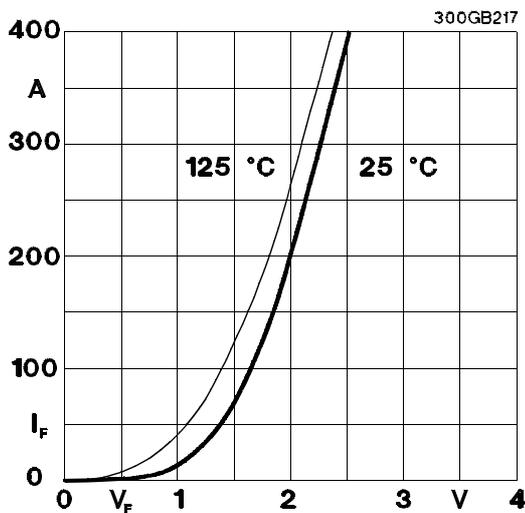


Fig. 17 Typ. CAL diode forward characteristic

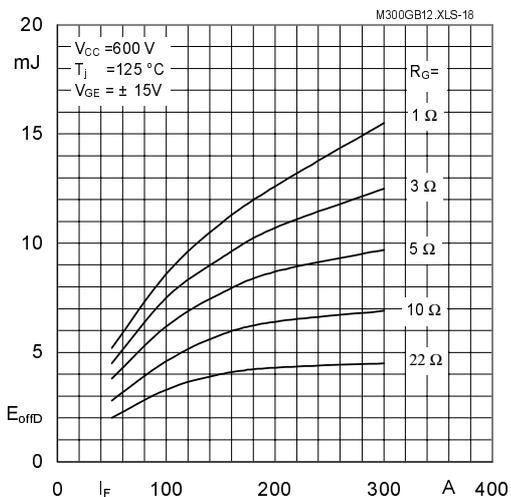


Fig. 18 Diode turn-off energy dissipation per pulse

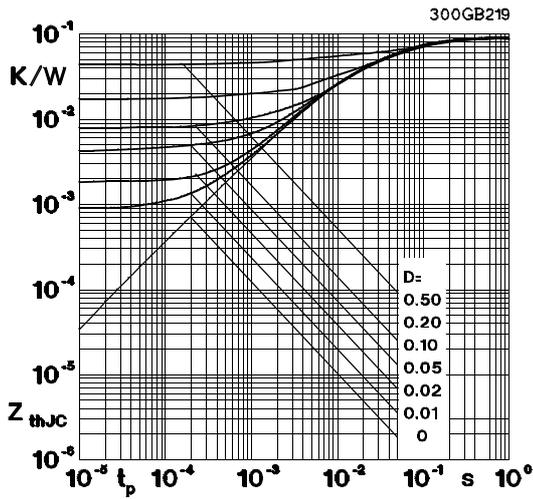


Fig. 19 Transient thermal impedance of IGBT  
 $Z_{thJC} = f(t_p)$ ;  $D = t_p / t_c = t_p \cdot f$

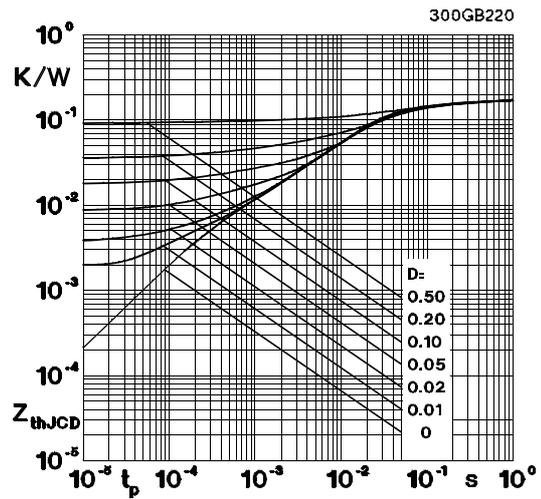


Fig. 20 Transient thermal impedance of inverse CAL diodes  
 $Z_{thJCD} = f(t_p)$ ;

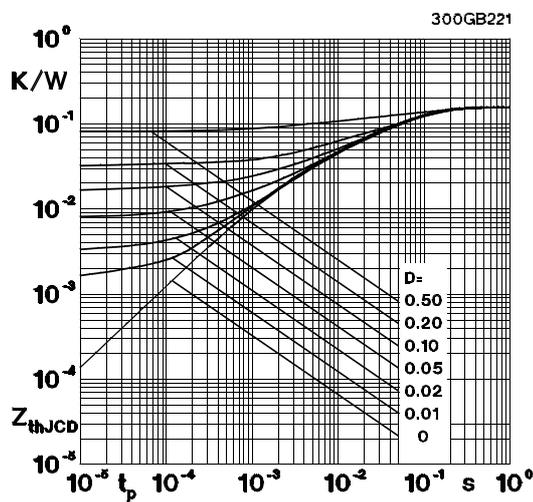


Fig. 21 Transient thermal impedance of the freewheeling diode  
 $Z_{thJCD} \rightarrow B 6 - 169, \text{ rem. } 6)$

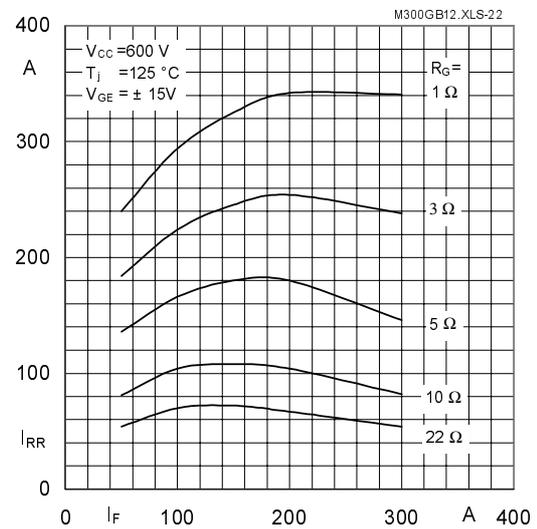


Fig. 22 Typ CAL diode reverse recovery current  
 $I_{RR} = f(I_F; R_G)$

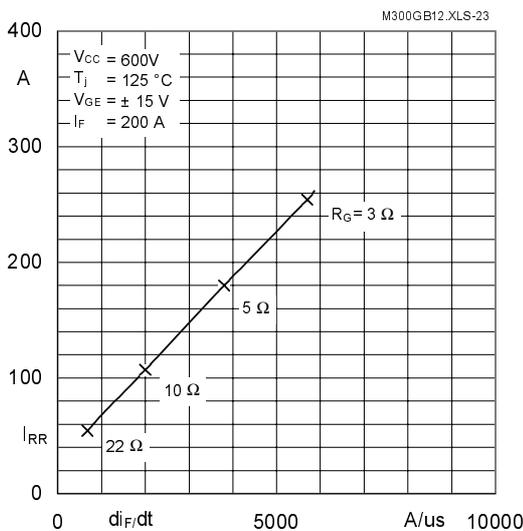


Fig. 23 Typ. CAL diode reverse recovery current  
 $I_{RR} = f(di_F/dt; R_G)$

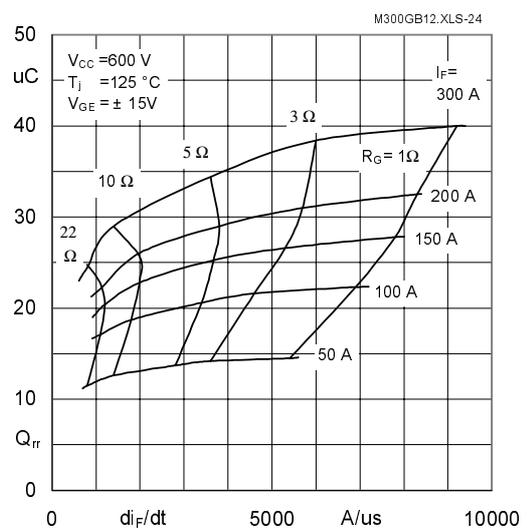


Fig. 24 Typ. CAL diode recovered charge  
 $Q_{rr} = f(di_F/dt; I_F; R_G)$

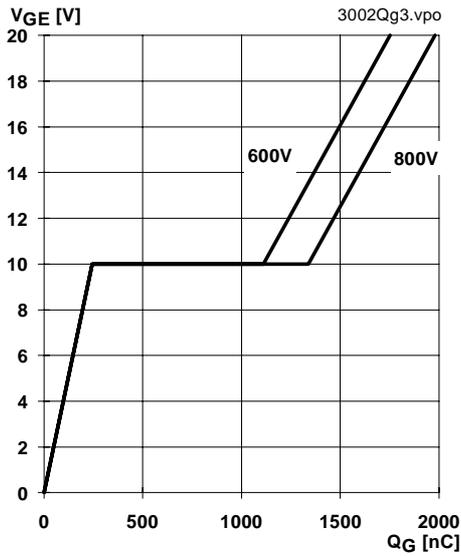
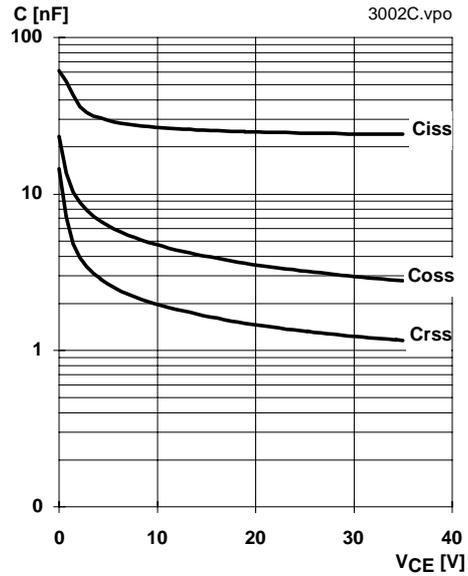


Fig. 13 Typ. gate charge characteristic

$I_{Cpuls} = 300 \text{ A}$



$V_{GE} = 0 \text{ V}$   
 $f = 1 \text{ MHz}$

Fig. 14 Typ. capacitances vs.  $V_{CE}$

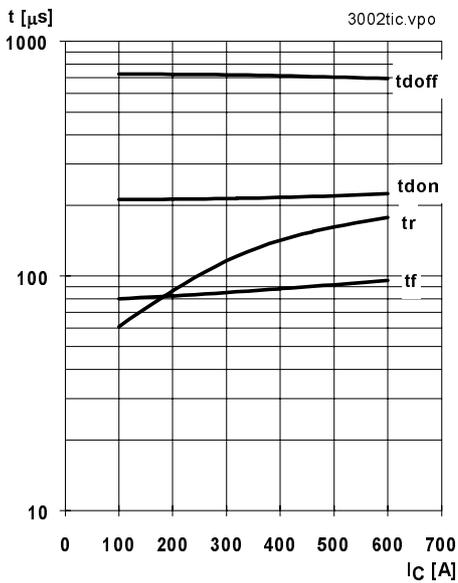
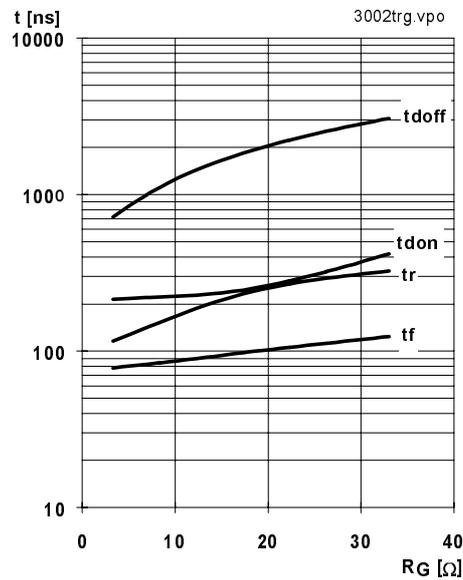


Fig. 15 Typ. switching times vs.  $I_c$

$T_j = 125 \text{ }^\circ\text{C}$   
 $V_{CE} = 600 \text{ V}$   
 $V_{GE} = \pm 15 \text{ V}$   
 $R_{Gon} = 3,3 \text{ } \Omega$   
 $R_{Goff} = 3,3 \text{ } \Omega$   
induct. load



$T_j = 125 \text{ }^\circ\text{C}$   
 $V_{CE} = 600 \text{ V}$   
 $V_{GE} = \pm 15 \text{ V}$   
 $I_c = 300 \text{ A}$   
induct. load

Fig. 16 Typ. switching times vs. gate resistor  $R_G$

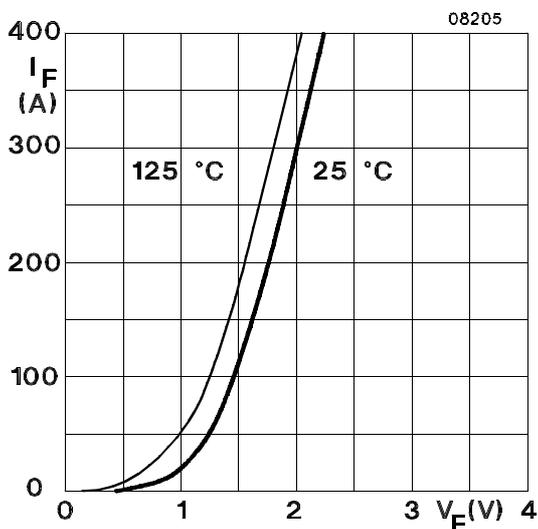


Fig. 17 Typ. CAL diode forward characteristic

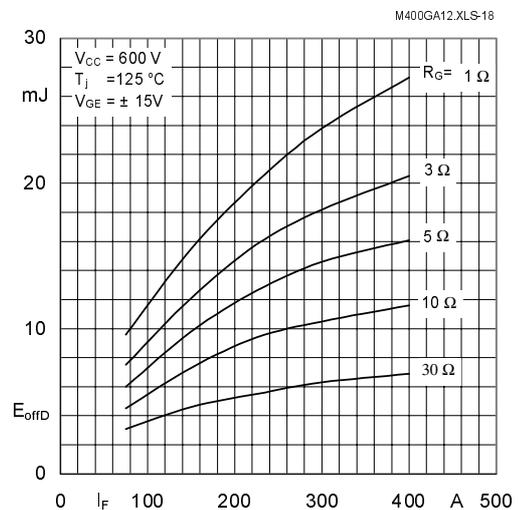


Fig. 18 Diode turn-off energy dissipation per pulse

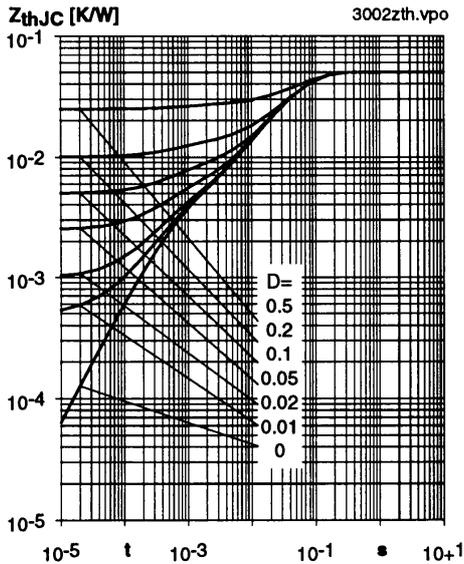


Fig. 19 Transient thermal impedance of IGBT  
 $Z_{thJC} = f(t_p)$ ;  $D = t_p / t_c = t_p \cdot f$

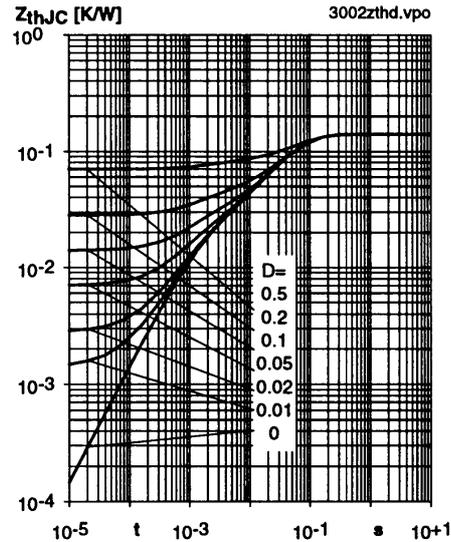


Fig. 20 Transient thermal impedance of inverse CAL diodes  
 $Z_{thJC} = f(t_p)$ ;  $D = t_p / t_c = t_p \cdot f$

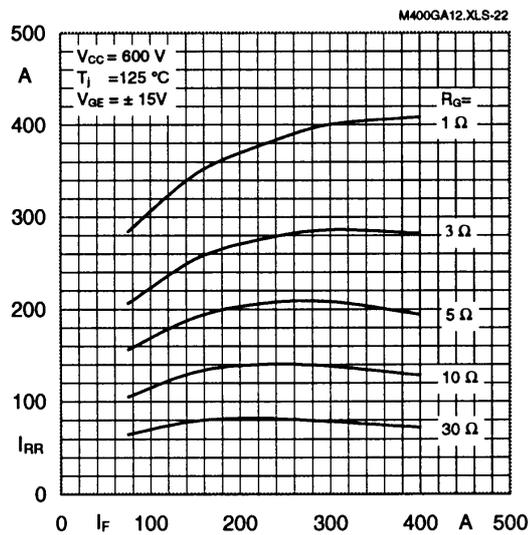


Fig. 22 Typ. CAL diode peak reverse recovery current  $I_{RR} = f(I_F; R_G)$

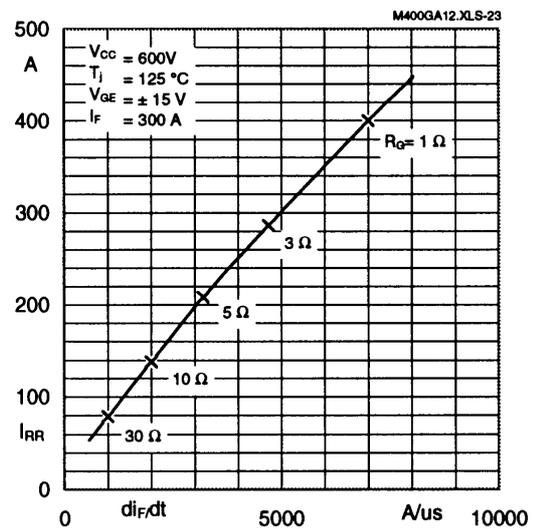


Fig. 23 Typ. CAL diode peak reverse recovery current  $I_{RR} = f(di/dt)$

## Typical Applications include

- Switched mode power supplies
- DC servo and robot drives
- Inverters
- DC choppers
- AC motor speed control
- Inductive heating
- UPS Uninterruptable power supplies
- General power switching applications
- Electronic (also portable) welders

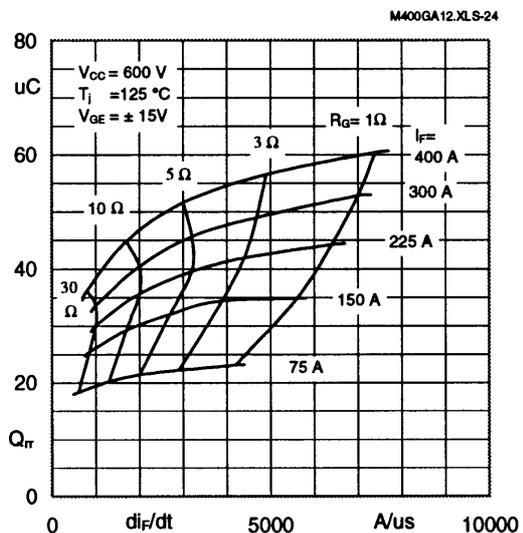


Fig. 24 Typ. CAL diode recovered charge